

THCV226 Application Note

System Diagram and PCB Design Guideline

Copyright© 2023, THine Electronics, Inc.



Contents

Contents	2
Application Diagrams	3
Selection Table	3
Normal LVDS Mode	4
HSLVDS Mode	5
Normal LVDS with Crossing Mode	6
HSLVDS with Crossing Mode	7
Normal LVDS with Distribution Mode 1	
HSLVDS with Distribution Mode 1	9
Normal LVDS with Distribution Mode 2	10
HSLVDS with Distribution Mode 2	11
Recommendations for Power Supply	12
Note	13
PCB Layout Considerations	16
Notices and Requests	17



Application Diagrams

Selection Table





Application Diagram (Case1) Normal LVDS Mode





Application Diagram (Case2) HSLVDS Mode





Application Diagram (Case3) Normal LVDS with Crossing Mode





Application Diagram (Case4) HSLVDS with Crossing Mode





Application Diagram (Case5) Normal LVDS with Distribution Mode 1





Application Diagram (Case6) HSLVDS with Distribution Mode 1





Application Diagram (Case7) Normal LVDS with Distribution Mode 2





Application Diagram (Case8) HSLVDS with Distribution Mode 2





Recommendations for Power Supply

- Separate the power domains into VVDD, LVDD(/LPVDD), CVDD(/IOVDD), and PVDD in order to avoid unwanted noise coupling between noisy digital and sensitive analog domains.
- Use high frequency ceramic capacitors of 10nF or 0.1µF as bypass capacitors between power and ground pins. Place them as close to each power pin as possible.
- Adding 4.7µF capacitors to PLL's power pins including V-by-One® HS power domain, along with the smaller bypass capacitors, is recommended.



Recommended Power Supply for THCV226



<u>Note</u>

1) LVDS Output Pin Connection

In case that the LVDS Rx of destination device is equipped with pull-up resistors connected to higher than THCV226's VDD voltage, this can cause violation of absolute maximum ratings to THCV226. This phenomenon may be happened at power-on phase and Hi-Z state of the whole system including LVDS Rx device.

One solution for this problem is power-down control for LVDS Rx device during no LVDS input or Hi-Z state period, if its pull-up resistors can be cut off at power-down state. Another solution is to set THCV226's OPF option pin to VDD. This setting provides low fixed data output mode at PDN = H, not Hi-Z state mode.



2) Cable Connection and Disconnection

Do Not connect and disconnect the LVDS and CML cable, when the power is supplied to the system.

3) GND Connection

Connect the each GND of the PCB which Transmitter and THCV226 on it. It is better for EMI reduction to place GND cable as close to LVDS and CML cable as possible.

4) Multi-drop Connection

Multi-drop connection is not recommended.





5) Multiple Counterpart Use

Multiple counterpart use such as the following system is not recommended. If it is not avoidable, please check whether <u>tRISK and tRIJT spec of THCV226</u> can be kept or not.



6) Multiple Device Connection

HTPDN and LOCKN signals are supposed to be connected properly for their purpose like the following figure. HTPDN should be from just one THCV226 to multiple Tx devices because its purpose is only ignition of all Tx devices. LOCKN should be connected so as to indicate that CDR status of all Rx devices becomes ready to receive normal operation data. LOCKN of Tx side can be simply split to multiple Tx devices. THCV226's DGLOCK is appropriate for multiple Rx use.

Also possible time difference of internal processing time (<u>THCV226 tRDC</u>) on multiple data stream must be accommodated and compensated by the following destination device connected to multiple THCV226 chips, which may have internal FIFO.





7) LVDS Link Skew Consideration Single Chip Case in use of Only One Clock Signal out of LVDS Channels :

Let tRCOP = 13.47ns (74.25MHz) at normal LVDS mode.

As a result, the total amount of LVDS skew, tROP1, is calculated as +/- 750ps in use of only one clock signal out of LVDS channels for the connection between THCV226 and destination device.





PCB Layout Considerations

- Use at least four-layer PCBs with signals, ground, power, and signals assigned for each layer. (Refer to figure below.)
- PCB traces for high-speed signals must be single-ended micorstirp lines or coupled microstrip lines whose differential characteristic impedance is 100Ω.
- Minimize the distance between traces of a differential pair (S1) to maximize common mode rejection and coupling effect which works to reduce EMI(Electro-Magnetic Interference).
- Route differential signal traces symmetrically.
- Avoid right-angle turns or minimize the number of vias on the high speed traces because they usually cause impedance discontinuity in the transmission lines and degrade the signal integrity.
- Mismatch among impedances of PCB traces, connectors, or cables, also causes reflection, limiting the bandwidth of the high-speed channels.
- Using common-mode filter on differential traces is desirable to reduce EMI. Pay attention on data-rate driven noise. For example, if data-rate is 1.5Gbps, common mode choke coil of 1.5GHz common mode impedance is desired to be high, while 1.5GHz differential impedance is low.





Notices and Requests

- 1. The product specifications described in this material are subject to change without prior notice.
- 2. The circuit diagrams described in this material are examples of the application which may not always apply to the customer's design. Thine Electronics, Inc. ("THine") is not responsible for possible errors and omissions in this material. Please note even if errors or omissions should be found in this material, Thine may not be able to correct them immediately.
- 3. This material contains THine's copyright, know-how or other intellectual property rights. Copying, reverse-engineer or disclosing to third parties the contents of this material without THine's prior written permission is prohibited.
- 4. THINE ACCEPTS NO LIABILITY FOR ANY DAMAGE OR LOSS IN CONNECTION WITH ANY DISPUTE RELATING TO INTELLECTUAL PROPERTY RIGHTS BETWEEN THE USER AND ANY THIRD PARTY, ARISING OUT OF THIS PRODUCT, EXCEPT FOR SUCH DAMAGE OR LOSS IN CONNECTION WITH DISPUTES SUCCESSFULLY PROVED BY THE USER THAT SUCH DISPUTES ARE DUE SOLELY TO THINE. NOTE, HOWEVER, EVEN IN THE AFOREMENTIONED CASE, THINE ACCEPTS NO LIABILITY FOR SUCH DAMAGE OR LOSS IF THE DISPUTE IS CAUSED BY THE USER'S INSTRUCTION.
- 5. This product is not designed for applications that require extremely high-reliability/safety such as aerospace device, nuclear power control device, or medical device related to critical care, excluding when this product is specified for automotive use by THine and used it for that purpose. THine accepts no liability whatsoever for any damages, claims or losses arising out of the uses set forth above.
- 6. Despite our utmost efforts to improve the quality and reliability of the product, faults will occur with a certain small probability, which is inevitable to a semi-conductor product. Therefore, you are encouraged to have sufficiently fail-safe design principles such as redundant or error preventive design applied to the use of the product so as not to have our product cause any social or public damage.
- 7. This product may be permanently damaged and suffer from performance degradation or loss of mechanical functionality if subjected to electrostatic charge exceeding capacity of the ESD (Electrostatic Discharge) protection circuitry. Safety earth ground must be provided to anything in contact with the product, including any operator, floor, tester and soldering iron.
- 8. Please note that this product is not designed to be radiation-proof.
- 9. Testing and other quality control techniques are used to this product to the extent THine deems necessary to support warranty for performance of this product. Except where mandated by applicable law or deemed necessary by THine based on the user's request, testing of all functions and performance of the product is not necessarily performed.
- 10. This product must be stored according to storage method which is specified in this specifications. Thine accepts no liability whatsoever for any damage or loss caused to the user due to any storage not according to above-mentioned method.
- 11. Customers are asked, if required, to judge by themselves if this product falls under the category of strategic goods under the Foreign Exchange and Foreign Trade Act in Japan and the Export Administration Regulations in the United States of America on export or transit of this product. This product is prohibited for the purpose of developing military modernization, including the development of weapons of mass destruction (WMD), and the purpose of violating human rights.
- 12. The product or peripheral parts may be damaged by a surge in voltage over the absolute maximum ratings or malfunction, if pins of the product are shorted by such as foreign substance. The damages may cause a smoking and ignition. Therefore, you are encouraged to implement safety measures by adding protection devices, such as fuses. Thine accepts no liability whatsoever for any damage or loss caused to the user due to use under a condition exceeding the limiting values.
- 13. All patents or pending patent applications, trademarks, copyrights, layout-design exploitation rights or other intellectual property rights concerned with this product belong to THine or licensor(s) of THine. No license or right is granted to the user for any intellectual property right or other proprietary right now or in the future owned by THine or THine's licensor. The user must enter into a license agreement with THine or THine's licensor to be granted of such license or right.

THine Electronics, Inc.

https://www.thine.co.jp